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- 1. A chemical mechanical polishing apparatus, comprising:
- a substrate holder to hold a substrate:
- a polishing belt having a polishing surface to contact at least a portion of the substrate held by the substrate holder while the polishing belt is moving in a first direction in a generally linear path relative to the substrate, the polishing belt having a plurality of grooves formed therein, the grooves having a depth of at least about 0.02 inches, a width of at least about 0.015 inches, and a pitch of at least about 0.09 inches; and
- a backing member positioned on a side of the polishing belt opposite the substrate
 - The apparatus of claim 1 wherein the grooves are uniformly spaced over the polishing surface.
 - The apparatus of claim 1 wherein the grooves have a depth between about 0.02 and 0.05 inches.
 - 4. The apparatus of claim 3 wherein the grooves have a depth of approximately 0.03 inches.
 - 5. The apparatus of claim l wherein the grooves have a width between about 0.015 and 0.04 inches.
- The apparatus of claim 5 wherein the grooves have a width of approximately
 0.02 inches.
 - 7. The apparatus of claim 1 wherein the grooves have a pitch between about 0.09 and 0.24 inches.
- 8. The apparatus of claim 7 wherein the grooves have a pitch of approximately 0.12 inches.

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- The apparatus of claim l, further comprising an actuator to urge the substrate and the belt into contact with one another for polishing.
- 10. The apparatus of claim I wherein a fluid layer is interposed between the
 5 membrane backing member and the polishing belt.
 - 11. The apparatus of claim 1 wherein the belt has a width at least as wide as the substrate holder.
- 10 12. The apparatus of claim 1 wherein the belt is driven continuously during polishing.
 - 13. The apparatus of claim 1 wherein the belt is driven periodically between polishing operations.
 - 14. The apparatus of claim 1 wherein the belt is a continuous belt.
 - 15. The apparatus of claim 1 wherein the belt extends between a feed and a take-up roller.
 - 16. The apparatus of claim 1 wherein the grooves are oriented substantially perpendicular to the first direction of motion.
- 17. The apparatus of claim 1 wherein the grooves include a first plurality of substantially linear grooves and a second plurality of substantially linear grooves oriented perpendicular to the first plurality of grooves.
 - 18. The apparatus of claim 1 wherein the grooves have an arcuate shape curved away from the first direction of motion.
 - 19. A chemical mechanical polishing apparatus, comprising: a substrate holder to hold a substrate:

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a polishing belt having a polishing surface to contact at least a portion of the substrate held by the substrate holder, the belt movable in a first direction in a generally linear path relative to the substrate, the polishing belt having a plurality of grooves formed therein, the grooves oriented substantially perpendicular to the first direction of motion; and

a backing member positioned on a side of the polishing belt opposite the substrate holder.

- 20. The apparatus of claim 19, wherein the plurality of grooves are substantially linear
 - 21. A chemical mechanical polishing apparatus, comprising:
 - a substrate holder to hold a substrate;
- a polishing belt having a polishing surface to contact at least a portion of the substrate held by the substrate holder, the polishing belt movable in a first direction in a generally linear path relative to the substrate, the polishing belt having a first plurality of substantially linear grooves and a second plurality of substantially linear grooves formed therein, the first plurality of grooves oriented substantially perpendicular to the second plurality of grooves; and
- a backing member positioned on a side of the polishing belt opposite the substrate holder.
- 22. The apparatus of claim 21 wherein the first plurality of grooves is oriented substantially perpendicular to the first direction.
- 23. The apparatus of claim 21 wherein the first and second pluralities of grooves are oriented at about 45 degrees to the first direction.
 - 24. A chemical mechanical polishing apparatus, comprising:
- 30 a substrate holder to hold a substrate:
 - a polishing belt having a polishing surface to contact at least a portion of the substrate held by the substrate holder, the polishing belt movable in a first direction in a generally linear path relative to the substrate, the polishing belt having a plurality of

arcuate grooves formed therein, the grooves oriented substantially perpendicular to the first direction of motion; and

a backing member positioned on a side of the polishing belt opposite the substrate holder.

25. The apparatus of claim 24 wherein the arcuate grooves are bowed away from the first direction.